

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/544,289	HIYOSHI, TAKAYUKI	
		Examiner	Art Unit	Page 1 of 1
		Hai C. Pham	2861	

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,121,993	09-2000	Maekawara et al.	347/236
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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**FOREIGN PATENT DOCUMENTS**

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